

Track-based alignment of the CMS muon detector



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American Physical Society April Meeting April 12, 2008 (B12.00006)

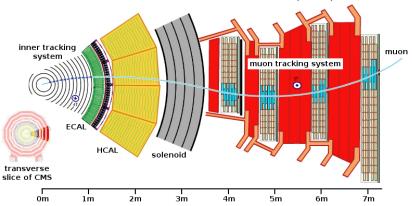
CMS muon tracking system

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Outermost part of the Compact Muon Solenoid (CMS)



- ▶ Typical muon leaves a trail of 24–44 hits in muon system
- A complete tracking system in itself!
- Measure muon momentum by curvature of its 7-meter long track

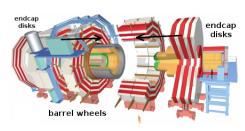
Independent components

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- Built in an assembly hall and lowered, piece by piece, to the interaction point
- Iron disks shift and bend centimeters in CMS's 4-Tesla magnetic field
- ➤ 790 chambers mounted on ball-joints to remain internally rigid

Hit resolution depends on precise knowledge of chambers' position and orientation in space

Does muon alignment matter? Jim Pivarski 4/16

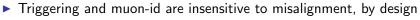


- ▶ Triggering and muon-id are insensitive to misalignment, by design
- ▶ Inner tracker dominates in p_T resolution because hits are \sim 10 times more precise
 - \blacktriangleright Inner tracker: 10–50 $\mu\mathrm{m}$ silicon strip measurements
 - \blacktriangleright Muon chamber: 200 μ m drift tubes and cathode strips

Does muon alignment matter? Jim Pivarski

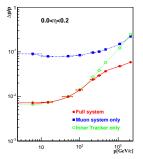


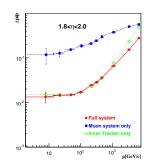
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- ▶ Inner tracker dominates in p_T resolution because hits are \sim 10 times more precise
 - ▶ Inner tracker: $10-50 \mu m$ silicon strip measurements
 - Muon chamber: 200 μ m drift tubes and cathode strips

... but only below 1 TeV





▶ TeV tracks are so straight that muon system's lever arm contributes significantly to momentum resolution: it matters!

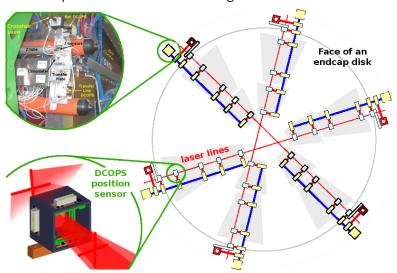
Hardware alignment system Jim Pivarski





System of lasers and calipers mounted on chambers

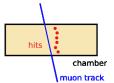
Measure positions and monitor changes



Track-based alignment

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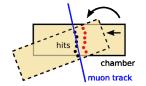
Find corrections to assumed chamber positions by minimizing track-minus-hit residuals

- ▶ Independent alternative to Muon Hardware Alignment System
- ▶ Aligns active sensors directly, rather than the boxes they live in
- ► Parameter resolution is proportional to sensitivity of track-fitting: best resolution on the parameters that matter most

Track-based alignment

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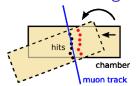




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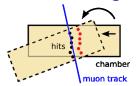
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Challenges and solutions

- Ordinarily, a chicken-and-egg problem: tracks are fit by minimizing residuals, too!
 - We can use the inner silicon tracker as a reference





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Challenges and solutions

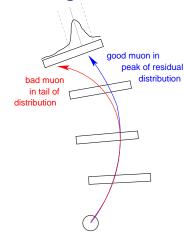
- Ordinarily, a chicken-and-egg problem: tracks are fit by minimizing residuals, too!
 - We can use the inner silicon tracker as a reference
- ▶ Muon system has a lot of iron: multiple-scattering distorts track
 - 1. Remove highly scattering tracks from sample
 - 2. Re-fit tracks using local information

Muon Alignment Techniques

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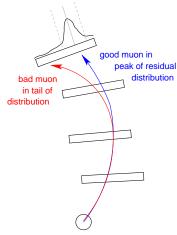


- Use redundancy of muon system to identify multiply-scattering tracks
 - Scattered tracks are in tails of the residual distributions
 - Dozens of residual distributions per track: one for each layer hit
- Scattering bias is antisymmetric with charge, only affects low momentum

Muon Alignment Techniques

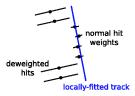
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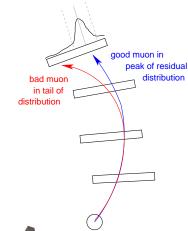
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Muon Alignment Techniques

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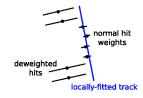




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- Some chambers overlap without intervening iron layer
 - ▶ local-fit shared track segment
 - align chambers relative to one another

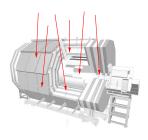


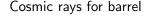
Start-up alignment methods

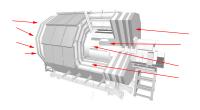
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Beam-halo for endcaps

Strategy:

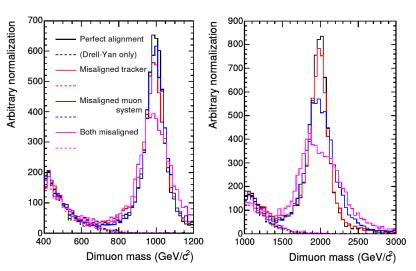
- Find relative chamber alignments within modular structures (barrel wheels and endcap disks) using cosmics, beam-halo
- 2. Align modular structures to inner tracker with first collisions
 - ► These structures cover large solid angles
 - Not many tracks are needed for a precise alignment

TeV dimuons with misalignment Jim Pivarski 15/16





Simulated Z' peak shape with residual misalignment



Misaligned muon system matters a lot more at 2 TeV, as expected



- ► CMS muon detector is a many-layered tracking system
- ▶ Modular structure requires alignment
- ► Track-based alignment poses a unique set of challenges in this environment
- \triangleright Significant impact on early physics: width of Z' resonance